Combined Form PTO/SB/0	RA&B			Complete if Known		
				Application Number	09/745,996	
INFORM	IATION DISC	LOS	URE	Confirmation Number	1382	
STATEN	MENT BY API	PLIC	ANT	Filing Date	December 26, 2000	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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